PTO/SB/08a (07-09)

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Sub	Substitute for form 1449/PTO			Complete if Known	
				Application Number	10/697,534-Conf. #7591
IN	IFORMATION	I DI	SCLOSURE	Filing Date	October 30, 2003
S	TATEMENT B	3Y /	APPLICANT	First Named Inventor	Steve Shattil
				Art Unit	2611
	(Use as many sheets as necessary)			Examiner Name	K. Kim
Sheet	1	of	4	Attorney Docket Number	27592-00404-US3

			U.S. PA	TENT DOCUMENTS	
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Initials*	Cite	Foreign Patent Document	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages	- 6				
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Examiner	/V ovin Vim/	Date	05/04/0040
Signature	/Kevin Kim/	Considered	l 05/04/2010 l

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. * CITE NO.: Those application(s) which are marked with an single asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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	AK1*	US-7,082,153	07-25-2006	Balachandran et al.			
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Signature		Considered	*****

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		NON PATENT LITERATURE DOCUMENTS					
Examiner Cite Initials No.1		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
	CA	Jevremovic, "Smart Antenna Systems for CDMA (IS-95) Technology"; Microwave Online Servcies Co., US West Advanced Technologies white paper Feb. 1998					
	СВ	Kowalski, Hale, Shattile, "Broadband Continuous-Wave Laser," Optics Letters, Vol. 13, No. 8, August 1988, pp. 622-624					
	СС	Kowalski, Shattil, Hale, "Optical Pulse Generation with a Frequency Shifted Feedback Laser," Appl. Phys. Lett., Vol. 53, No. 9, 29 August 1988					
CD Kowalski, Squier, Pinckney, "Pulse Generation with an Acouslo-Optic Frequency Shifter in Passive Cavity," Appl. Phys. Lett., Vol. 50, No. 12, 23 March 1987							
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	CG	Wiegandt, "Peak-to-average power reduction in high-performance, high-throughput OFDM via pseudo-orthogonal carrier-interferometry coding," IEEE Pacific Rim Conference on Communications, Computers and signal Processing, 2001, PACRIM, 2001, vol. 2, Aug. 26-28, 2001 pp. 453-456, vol. 2					
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	CJ	Natarajan, "Crest factor considerations in MC-CDMA with carrier interferometry codes," PACRIM, 2001 IEEE Communications Pacific Rim Conference on Computers and signal Processing, 2001, vol. 2, Aug. 26-28, 2001, pp. 445-448, vol. 2					

Examiner Signature	/Kevin Kim/	Date Considered	05/04/2010
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NON PATENT LITERATURE DOCUMENTS							
Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume number(s), publisher, city and/or country where published.		T ²				
	СК	Wiegandt, "Overcoming peak-to-average power ratio issues in OFDM via carrier-interferometry codes," IEEE VTS 54th Vehicular Technology Conference, 2001, VTC 2001 Fall, vol. 2, Oct. 7-11, 2001, pp. 660-663, vol. 2					

Examiner	/Kevin Kim/	Date	05/04/2010
Signature	77.70	Considered	03/04/2010

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